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- Trimmed Offset Voltage: TLC27L9...900 μV Max at 25°C, V_{DD} = 5 V
- Input Offset Voltage Drift . . . Typically 0.1 μV/Month, Including the First 30 Days
- Wide Range of Supply Voltages Over Specified Temperature Range: 0°C to 70°C...3 V to 16 V -40°C to 85°C...4 V to 16 V -55°C to 125°C...4 V to 16 V
- Single-Supply Operation
- Common-Mode Input Voltage Range Extends Below the Negative Rail (C-Suffix, I-Suffix Types)
- Ultra-Low Power . . . Typically 195 μW at 25°C, V_{DD} = 5 V
- Output Voltage Range includes Negative Rail
- High Input Impedance . . . $10^{12} \Omega$ Typ
- ESD-Protection Circuitry
- Small-Outline Package Option Also Available in Tape and Reel
- Designed-In Latch-Up Immunity

description

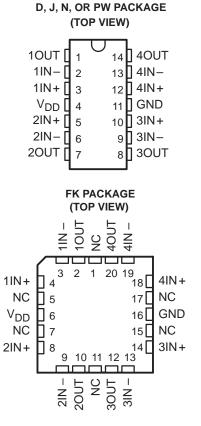
The TLC27L4 and TLC27L9 quad operational amplifiers combine a wide range of input offset voltage grades with low offset voltage drift, high input impedance, extremely low power, and high gain.

These devices use Texas instruments silicon-gate LinCMOS[™] technology, which provides offset voltage stability far exceeding the stability available with conventional metal-gate processes.

The extremely high input impedance, low bias currents, and low-power consumption make these cost-effective devices ideal for high-gain, low- frequency, low-power applications. Four offset voltage grades are available (C-suffix and I-suffix types), ranging from the low-cost TLC27L4 (10 mV) to the high-precision TLC27L9 (900 μ V). These advantages, in combination with good common-mode rejection and supply voltage rejection, make these devices a good choice for new state-of-the-art designs as well as for upgrading existing designs.

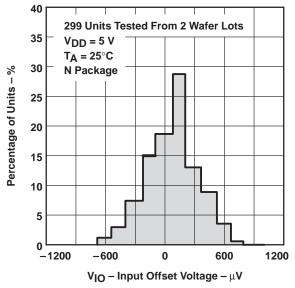
LinCMOS is a trademark of Texas Instruments Incorporated.





NC – No internal connection

DISTRIBUTION OF TLC27L9 INPUT OFFSET VOLTAGE



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description (continued)

In general, many features associated with bipolar technology are available on LinCMOS[™] operational amplifiers, without the power penalties of bipolar technology. General applications such as transducer interfacing, analog calculations, amplifier blocks, active filters, and signal buffering are easily designed with the TLC27L4 and TLC27L9. The devices also exhibit low voltage single-supply operation and ultra-low power consumption, making them ideally suited for remote and inaccessible battery-powered applications. The common-mode input voltage range includes the negative rail.

A wide range of packaging options is available, including small-outline and chip-carrier versions for high-density system applications.

The device inputs and outputs are designed to withstand –100-mA surge currents without sustaining latch-up.

The TLC27L4 and TLC27L9 incorporate internal ESD-protection circuits that prevent functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2; however, care should be exercised in handling these devices, as exposure to ESD may result in the degradation of the device parametric performance.

The C-suffix devices are characterized for operation from 0° C to 70° C. The I-suffix devices are characterized for operation from -40° C to 85° C. The M-suffix devices are characterized for operation from -55° C to 125° C.

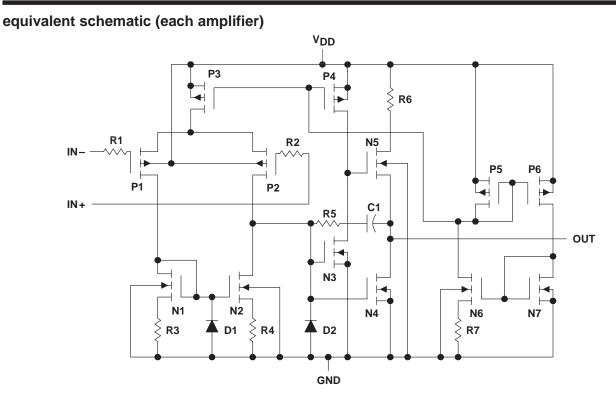
| | | | PA | CKAGED DEVIC | ES | | |
|----------------|--------------------------------|-------------------------|-------------------------|-----------------------|-----------------------|---------------|---------------------|
| TA | V _{IO} max AT 25°C | SMALL OUTLINE (D) | CHIP CARRIER (FK) | CERAMIC DIP (J) | PLASTIC DIP (N) | TSSOP (PW) | CHIP FORM (Y) |
| | 900 μV | TLC27L9CD | — | — | TLC27L9CN | — | — |
| 0°C to 70°C | 2 mV | TLC27L4BCD | — | — | TLC27L4BCN | — | — |
| 0.01070.0 | 5 mV | TLC27L4ACD | _ | — | TLC27L4ACN | — | — |
| | 10 mV | TLC27L4CD | — | — | TLC27L4CN | TLC27L4CPW | TLC27L4Y |
| | 900 μV | TLC27L9ID | — | — | TLC27L9IN | — | — |
| -40°C to 85°C | 2 mV | TLC27L4BID | — | — | TLC27L4BIN | — | — |
| -40°C 10 85°C | 5 mV | TLC27L4AID | — | — | TLC27L4AIN | — | — |
| | 10 mV | TLC27L4ID | _ | — | TLC27L4IN | — | — |
| -55°C to 125°C | 900 μV | TLC27L9MD | TLC27L9MFK | TLC27L9MJ | TLC27L9MN | — | — |
| -55 C 10 125 C | 10 mV | TLC27L4MD | TLC27L4MFK | TLC27L4MJ | TLC27L4MN | — | — |

AVAILABLE OPTIONS

The D package is available taped and reeled. Add R suffix to the device type (e.g., TLC27L9CDR).



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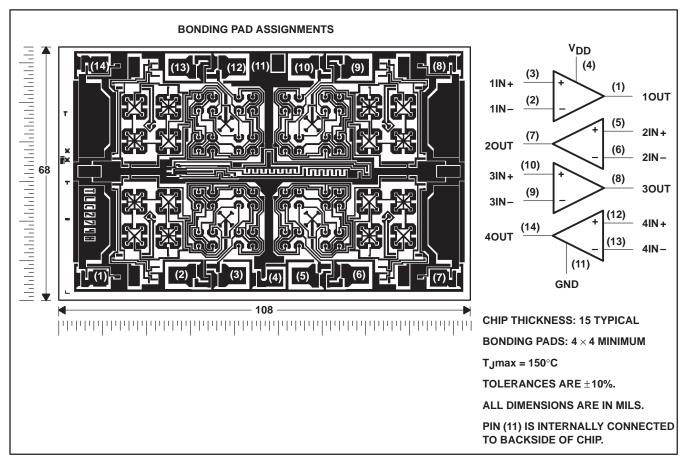




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TLC27L4Y chip information

These chips, when properly assembled, display characteristics similar to the TLC27L4C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.





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absolute maximum ratings over operating free-air temperature (unless otherwise noted)[†]

| Differential input voltage, V _{ID} (see Input voltage range, V _I (any input) Input current, I _I Output current, I _O (each output) . Total current into V _{DD} | Note 2) | $\begin{array}{c} & \pm V_{DD} \\ & -0.3 \text{ V to } V_{DD} \\ & \pm 5 \text{ mA} \\ & & \pm 30 \text{ mA} \\ & & & 45 \text{ mA} \end{array}$ |
|--|----------------------------------|--|
| | (or below) 25°C (see Note 3) | |
| | | |
| | | |
| | C suffix | 0°C to 70°C |
| | | 0°C to 70°C |
| | C suffix | |
| Operating free-air temperature, T_A | C suffix I suffix M suffix | |
| Operating free-air temperature, T _A : Storage temperature range | C suffix | 0°C to 70°C 40°C to 85°C 55°C to 125°C 65°C to 150°C |
| Operating free-air temperature, T _A Storage temperature range Case temperature for 60 seconds: Lead temperature 1,6 mm (1/16 inc | C suffix I suffix M suffix | 0°C to 70°C -40°C to 85°C -55°C to 125°C -65°C to 150°C 260°C W package |

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to network ground.

2. Differential voltages are at IN+ with respect to IN-.

3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded (see application section).

| | | DISSIPATION RA | ATING TABLE | | |
|---------|------------------------------------|--|---------------------------------------|---------------------------------------|--|
| PACKAGE | $T_A \le 25^{\circ}C$ POWER RATING | DERATING FACTOR ABOVE T _A = 25°C | T _A = 70°C POWER RATING | T _A = 85°C POWER RATING | T _A = 125°C POWER RATING |
| D | 950 mW | 7.6 mW/°C | 608 mW | 494 mW | _ |
| FK | 1375 mW | 11.0 mW/°C | 880 mW | 715 mW | 275 mW |
| J | 1375 mW | 11.0 mW/°C | 880 mW | 715 mW | 275 mW |
| N | 1575 mW | 12.6 mW/°C | 1008 mW | 819 mW | — |
| PW | 700 mW | 5.6 mW/°C | 448 mW | _ | — |

DISSIPATION RATING TABLE

recommended operating conditions

| | | C SU | FFIX | I SUI | FFIX | M SU | FFIX | UNIT |
|---------------------------------------|------------------------|------|------|-------|------|------|------|------|
| | | MIN | MAX | MIN | MAX | MIN | MAX | UNIT |
| Supply voltage, V _{DD} | | 3 | 16 | 4 | 16 | 4 | 16 | V |
| | $V_{DD} = 5 V$ | -0.2 | 3.5 | -0.2 | 3.5 | 0 | 3.5 | V |
| Common-mode input voltage, VIC | V _{DD} = 10 V | -0.2 | 8.5 | -0.2 | 8.5 | 0 | 8.5 | v |
| Operating free-air temperature, T_A | | 0 | 70 | -40 | 85 | -55 | 125 | °C |



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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS | τ _A † | ТІ ТІ | _C27L4(_C27L4/ _C27L4E _C27L4E _C27L9(| AC BC | UNIT |
|------|--|---------------------|----------------------------------|-------------------------|------------------|-------------------|---|----------|-------|
| | | | | | | MIN | TYP | MAX | |
| | | TLC27L4C | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 1.1 | 10 | |
| | | TLC27L4C | $R_{S} = 50 \Omega$, | $R_L = 1 M\Omega$ | Full range | | | 12 | |
| | | TLC27L4AC | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 0.9 | 5 | mV |
| Vie | Input offset voltage | TLC27L4AC | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 6.5 | |
| VIO | input onset voltage | TLC27L4BC | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 240 | 2000 | |
| | | 120272400 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 3000 | μV |
| | | TLC27L9C | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 200 | 900 | μv |
| | | 12027230 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 1500 | |
| ανιο | Average temperature co offset voltage | pefficient of input | | | 25°C to 70°C | | 1.1 | | μV/°C |
| | Input offect ourrest (oor | Note () | | | 25°C | | 0.1 | | ~^ |
| 10 | Input offset current (see | e Note 4) | V _O = 2.5 V, | $V_{IC} = 2.5 V$ | 70°C | | 7 | 300 | pА |
| | Input biog ourrest (see | Nata () | | | 25°C | | 0.6 | | - |
| IВ | Input bias current (see | Note 4) | V _O = 2.5 V, | V _{IC} = 2.5 V | 70°C | | 40 | 600 | pА |
| | Common mode input vo | oltage range | | | 25°C | -0.2 to 4 | -0.3 to 4.2 | | V |
| VICR | (see Note 5) | | | | Full range | -0.2 to 3.5 | | | V |
| | | | | | 25°C | 3.2 | 4.1 | | |
| Vон | High-level output voltag | e | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | 0°C | 3 | 4.1 | | V |
| | | | | | 70°C | 3 | 4.2 | | |
| | | | | | 25°C | | 0 | 50 | |
| VOL | Low-level output voltage | e | V _{ID} = -100 mV, | IOT = 0 | 0°C | | 0 | 50 | mV |
| | | | | | 70°C | | 0 | 50 | |
| | | | | | 25°C | 50 | 520 | | |
| AVD | Large-signal differential amplification | voltage | $V_{O} = 2.5 V \text{ to } 2 V,$ | $R_L = 1 M\Omega$ | 0°C | 50 | 680 | | V/mV |
| | ampinoation | | | | 70°C | 50 | 380 | | |
| | | | | | 25°C | 65 | 94 | | |
| CMRR | Common-mode rejection | n ratio | $V_{IC} = V_{ICR}min$ | | 0°C | 60 | 95 | | dB |
| | | | | | 70°C | 60 | 95 | | |
| | Currente under state st | | | | 25°C | 70 | 97 | | |
| ksvr | Supply-voltage rejection (ΔVDD/ΔVIO) | i ratio | $V_{DD} = 5 V \text{ to } 10 V,$ | V _O = 1.4 V | 0°C | 60 | 97 | | dB |
| | ······································ | | | | 70°C | 60 | 98 | | |
| | | | V _O = 2.5 V, | | 25°C | | 40 | 68 | |
| IDD | Supply current (four am | plifiers) | VO = 2.5 V, No load | $V_{IC} = 2.5 V,$ | 0°C | | 48 | 84 | μA |
| | | | | | 70°C | | 31 | 56 | |

[†] Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS | T _A † | | .C27L4(.C27L4/ .C27L4E .C27L4E | AC BC | UNIT |
|-------------|--|---------------|----------------------------------|------------------------|------------------|-------------------|--|----------|-------|
| | | | | | | MIN | TYP | MAX | |
| | | TLC27L4C | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 1.1 | 10 | |
| | | 12027240 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 12 | mV |
| | | TLC27L4AC | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 0.9 | 5 | IIIV |
| VIO | Input offset voltage | TLO27L4AC | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 6.5 | |
| ۷IO | input onset voltage | TLC27L4BC | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 260 | 2000 | |
| | | TEO27E4DC | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 3000 | μV |
| | | TLC27L9C | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 210 | 1200 | μv |
| | | 12027290 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 1900 | |
| αVIO | Average temperature co input offset voltage | pefficient of | | | 25°C to 70°C | | 1 | | μV/°C |
| | | | | Х. Б.Х. | 25°C | | 0.1 | | 4 |
| IIO | Input offset current (see | e Note 4) | V _O = 5 V, | VIC = 5 V | 70°C | | 7 | 300 | pА |
| | | | | Х. Б.Х. | 25°C | | 0.7 | | 4 |
| IВ | Input bias current (see | Note 4) | V _O = 5 V, | V _{IC} = 5 V | 70°C | | 50 | 600 | рA |
| ., <i>,</i> | Common-mode input vo | oltage range | | | 25°C | -0.2 to 9 | -0.3 to 9.2 | | V |
| VICR | (see Note 5) | 0 0 | | | Full range | -0.2 to 8.5 | | | V |
| | | | | | 25°C | 8 | 8.9 | | |
| Vон | High-level output voltag | e | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | 0°C | 7.8 | 8.9 | | V |
| | | | | | 70°C | 7.8 | 8.9 | | |
| | | | | | 25°C | | 0 | 50 | |
| Vol | Low-level output voltage | е | $V_{ID} = -100 \text{ mV},$ | IOT = 0 | 0°C | | 0 | 50 | mV |
| | | | | | 70°C | | 0 | 50 | |
| | | | | | 25°C | 50 | 870 | | |
| Avd | Large-signal differential amplification | voltage | $V_{O} = 1 V \text{ to } 6 V,$ | $R_L = 1 M\Omega$ | 0°C | 50 | 1020 | | V/mV |
| | ampinoation | | | | 70°C | 50 | 660 | | |
| | | | | | 25°C | 65 | 97 | | |
| CMRR | Common-mode rejectio | n ratio | $V_{IC} = V_{ICR}min$ | | 0°C | 60 | 97 | | dB |
| | | | | | 70°C | 60 | 97 | | |
| | | | | | 25°C | 70 | 97 | | |
| ksvr | Supply-voltage rejection (ΔVDD/ΔVIO) | n ratio | $V_{DD} = 5 V \text{ to } 10 V,$ | V _O = 1.4 V | 0°C | 60 | 97 | | dB |
| | | | | | 70°C | 60 | 98 | | |
| | | | | | 25°C | | 57 | 92 | |
| IDD | Supply current (four am | plifiers) | $V_O = 5 V$, No load | V _{IC} = 5 V, | 0°C | | 72 | 132 | μΑ |
| | | | | | 70°C | | 44 | 80 | |

[†] Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS | TAţ | ТІ ТІ | _C27L4I _C27L4 <i>I</i> _C27L4E _C27L9I | AI BI | UNIT |
|--------------|---|---------------------|-----------------------------------|-------------------------|-----------------|-------------------|--|----------|-------|
| | | | | | | MIN | TYP | MAX | |
| | | TLC27L4I | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 1.1 | 10 | |
| | | 11027141 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 13 | mV |
| | | TLC27L4AI | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 0.9 | 5 | IIIV |
| VIO | Input offset voltage | | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 7 | |
| ٩O | input onset voltage | TLC27L4BI | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 240 | 2000 | |
| | | | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 3500 | μV |
| | | TLC27L9I | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 200 | 900 | μν |
| | | | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 2000 | |
| αΛΙΟ | Average temperature co offset voltage | pefficient of input | | | 25°C to 85°C | | 1.1 | | μV/°C |
| | Input offect ourrent (co | Note () | | | 25°C | | 0.1 | | ~^ |
| 10 | Input offset current (see | e Note 4) | V _O = 2.5 V, | V _{IC} = 2.5 V | 85°C | | 24 | 1000 | pА |
| | Input biog ourrent (one | Note () | | | 25°C | | 0.6 | | ~^ |
| IВ | Input bias current (see | Note 4) | V _O = 2.5 V, | V _{IC} = 2.5 V | 85°C | | 200 | 2000 | pА |
| | Common-mode input v | oltage range | | | 25°C | -0.2 to 4 | -0.3 to 4.2 | | V |
| VICR | (see Note 5) | 0 0 | | | Full range | -0.2 to 3.5 | | | V |
| | | | | | 25°C | 3.2 | 4.1 | | |
| Vон | High-level output voltage | e | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | -40°C | 3 | 4.1 | | V |
| | | | | | 85°C | 3 | 4.2 | | |
| | | | | | 25°C | | 0 | 50 | |
| Vol | Low-level output voltag | е | $V_{ID} = -100 \text{ mV},$ | $I_{OL} = 0$ | -40°C | | 0 | 50 | mV |
| | | | | | 85°C | | 0 | 50 | |
| | | | | | 25°C | 50 | 480 | | |
| AVD | Large-signal differentia amplification | voltage | $V_{O} = 0.25 V \text{ to } 2 V,$ | $R_L = 1 M\Omega$ | -40°C | 50 | 900 | | V/mV |
| | ampinoation | | | | 85°C | 50 | 330 | | |
| | | | | | 25°C | 65 | 94 | | |
| CMRR | Common-mode rejection | n ratio | $V_{IC} = V_{ICR}min$ | | -40°C | 60 | 95 | | dB |
| | | | | | 85°C | 60 | 95 | | |
| | Complex coltants and a st | , notio | | | 25°C | 70 | 97 | | |
| k SVR | Supply-voltage rejection (ΔVDD/ΔVIO) | n ratio | $V_{DD} = 5 V \text{ to } 10 V,$ | V _O = 1.4 V | -40°C | 60 | 97 | | dB |
| | ······································ | | | | 85°C | 60 | 98 | | |
| | | | | | 25°C | | 39 | 68 | |
| IDD | Supply current (four an | plifiers) | $V_{O} = 2.5 V$, No load | $V_{IC} = 2.5 V,$ | -40°C | | 62 | 108 | μA |
| | | | | | 85°C | | 29 | 52 | |

[†] Full range is -40° C to 85° C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS | TAţ | ТІ ТІ | -C27L4I -C27L4/ -C27L4E -C27L9I | AI 31 | UNIT |
|------|--|--------------------|----------------------------------|------------------------|-----------------|-------------------|--|----------|-------|
| | | | | | | MIN | TYP | MAX | |
| | | TLC27L4I | V _O = 1.4 V, | V _{IC} = 0, | 25°C | | 1.1 | 10 | |
| | | 11027141 | $R_{S} = 50 \Omega$, | $R_L = 1 M\Omega$ | Full range | | | 13 | mV |
| | | TLC27L4AI | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 0.9 | 5 | IIIV |
| VIO | Input offset voltage | TLO27L4AI | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 7 | |
| ۷IO | input onset voltage | TLC27L4BI | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 260 | 2000 | |
| | | 160276401 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 3500 | μV |
| | | TLC27L9I | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 210 | 1200 | μv |
| | | 16027691 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 2900 | |
| ανιο | Average temperature co offset voltage | efficient of input | | | 25°C to 85°C | | 1 | | μV/°C |
| 1 | lanut effect summert (e.e.s | | | | 25°C | | 0.1 | | - 0 |
| ΙΟ | Input offset current (see | Note 4) | V _O = 5 V, | $V_{IC} = 5 V$ | 85°C | | 26 | 1000 | pА |
| l | lanut hing summer (as a h | ata (1) | | | 25°C | | 0.7 | | - 0 |
| IВ | Input bias current (see N | ote 4) | V _O = 5 V, | V _{IC} =.5 V | 85°C | | 220 | 2000 | рА |
| | Common-mode input vo | tage range | | | 25°C | -0.2 to 9 | -0.3 to 9.2 | | V |
| VICR | (see Note 5) | 0 0 | | | Full range | -0.2 to 8.5 | | | V |
| | | | | | 25°C | 8 | 8.9 | | |
| Vон | High-level output voltage | • | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | -40°C | 7.8 | 8.9 | | V |
| | | | | | 85°C | 7.8 | 8.9 | | |
| | | | | | 25°C | | 0 | 50 | |
| Vol | Low-level output voltage | | $V_{ID} = -100 \text{ mV},$ | $I_{OL} = 0$ | -40°C | | 0 | 50 | mV |
| | | | | | 85°C | | 0 | 50 | |
| | | | | | 25°C | 50 | 800 | | |
| AVD | Large-signal differential amplification | voltage | $V_{O} = 1 V \text{ to } 6 V,$ | $R_L = 1 M\Omega$ | -40°C | 50 | 1550 | | V/mV |
| | | | | | 85°C | 50 | 585 | | |
| | | | | | 25°C | 65 | 97 | | |
| CMRR | Common-mode rejection | ratio | $V_{IC} = V_{ICR}min$ | | -40°C | 60 | 97 | | dB |
| | | | | | 85°C | 60 | 98 | | |
| | | | | | 25°C | 70 | 97 | | |
| ksvr | Supply-voltage rejection $(\Delta V_{DD}/\Delta V_{IO})$ | ratio | $V_{DD} = 5 V \text{ to } 10 V,$ | V _O = 1.4 V | -40°C | 60 | 97 | | dB |
| | | | | | 85°C | 60 | 98 | | |
| | | | | | 25°C | | 57 | 92 | |
| IDD | Supply current (four amp | lifiers) | $V_{O} = 5 V$, No load | $V_{IC} = 5 V,$ | -40°C | | 98 | 172 | μA |
| | | | | | 85°C | | 40 | 72 | |

[†] Full range is -40° C to 85° C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

| | PARAMETER | | TEST CONI | DITIONS | т _А † | | .C27L4N .C27L9N | | UNIT |
|-------|--|------------------|------------------------------------|-------------------------|------------------|-------------------|--------------------|------|-------|
| | | | | | | MIN | TYP | MAX | |
| | | | V _O = 1.4 V, | VIC = 0, | 25°C | | 1.1 | 10 | |
| Vie | In put offect veltoge | TLC27L4M | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 12 | mV |
| VIO | Input offset voltage | TLC27L9M | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 200 | 900 | μV |
| | | 16276910 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 3750 | μv |
| αΛΙΟ | Average temperature coef offset voltage | ficient of input | | | 25°C to 125°C | | 1.4 | | μV/°C |
| | land offersterment (see N | - (- 1) | N 05V | | 25°C | | 0.1 | | pА |
| IO II | Input offset current (see N | ote 4) | V _O = 2.5 V, | VIC = 2.5 V | 125°C | | 1.4 | 15 | nA |
| | lanut hing summark (and hig | (a. 4) | | | 25°C | | 0.6 | | pА |
| IВ | Input bias current (see No | te 4) | V _O = 2.5 V, | V _{IC} = 2.5 V | 125°C | | 9 | 35 | nA |
| \/ | Common-mode input volta | ige range | | | 25°C | -0.2 to 4 | -0.3 to 4.2 | | V |
| VICR | (see Note 5) | | | | Full range | -0.2 to 3.5 | | | V |
| | | | | | 25°C | 3.2 | 4.1 | | |
| VOH | High-level output voltage | | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | −55°C | 3 | 4.1 | | V |
| | | | | | 125°C | 3 | 4.2 | | |
| | | | | | 25°C | | 0 | 50 | |
| VOL | Low-level output voltage | | $V_{ID} = -100 \text{ mV},$ | $I_{OL} = 0$ | −55°C | | 0 | 50 | mV |
| | | | | | 125°C | | 0 | 50 | |
| | | 11 | | | 25°C | 50 | 480 | | |
| AVD | Large-signal differential vo amplification | litage | $V_{O} = 0.25 V \text{ to } 2 V,$ | $R_L = 1 M\Omega$ | −55°C | 25 | 950 | | V/mV |
| | | | | | 125°C | 25 | 200 | | |
| | | | | | 25°C | 65 | 94 | | |
| CMRR | Common-mode rejection r | atio | $V_{IC} = V_{ICR}min$ | | -55°C | 60 | 95 | | dB |
| | | | | | 125°C | 60 | 85 | | |
| | Supply voltage rejection | tio | | | 25°C | 70 | 97 | | |
| ksvr | Supply-voltage rejection ra $(\Delta V_{DD}/\Delta V_{IO})$ | 110 | $V_{DD} = 5 V \text{ to } 10 V,$ | V _O = 1.4 V | −55°C | 60 | 97 | | dB |
| | | | | | 125°C | 60 | 98 | | |
| | | | | | 25°C | | 39 | 68 | |
| IDD | Supply current (four ampli | fiers) | V _O = 2.5 V, No load | vIC = 2.5 V, | −55°C | | 69 | 120 | μA |
| | | | | | 125°C | | 27 | 48 | |

[†] Full range is -55° C to 125° C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

| | PARAMETER | | TEST CON | DITIONS | τ _A † | | LC27L4N LC27L9N | | UNIT |
|--------------|--|--------------|----------------------------------|------------------------|------------------|----------------|--------------------|------|-------|
| | | | | - | | MIN | TYP | MAX | |
| | | TLC27L4M | V _O = 1.4 V, | VIC = 0, | 25°C | | 1.1 | 10 | mV |
| VIO | Input offset voltage | 1 LC27 L4101 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 12 | IIIV |
| ٥I٧ | input onset voltage | TLC27L9M | V _O = 1.4 V, | $V_{IC} = 0,$ | 25°C | | 210 | 1200 | μV |
| | | 102703101 | R _S = 50 Ω, | $R_L = 1 M\Omega$ | Full range | | | 4300 | μv |
| αΛΙΟ | Average temperature coei input offset voltage | fficient of | | | 25°C to 125°C | | 1.4 | | μV/°C |
| lio. | Input offset current (see N | loto (1) | V _O = 5 V, | VIC = 5 V | 25°C | | 0.1 | | pА |
| 10 | input onset current (see N | 10(8 4) | $v_0 = 3 v$, | VIC = 5 V | 125°C | | 1.8 | 15 | nA |
| lin | Input bias current (see No | (A) | V _O = 5 V, | V _{IC} = 5 V | 25°C | | 0.7 | | pА |
| IΒ | | | v0-3 v, | | 125°C | | 10 | 35 | nA |
| Vien | Common-mode input volta | age range | | | 25°C | 0 to 9 | -0.3 to 9.2 | | V |
| VICR | (see Note 5) | | | | Full range | 0 to 8.5 | | | V |
| | | | | | 25°C | 8 | 8.9 | | |
| Vон | High-level output voltage | | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | −55°C | 7.8 | 8.8 | | V |
| | | | | | 125°C | 7.8 | 9 | | |
| | | | | | 25°C | | 0 | 50 | |
| VOL | Low-level output voltage | | $V_{ID} = -100 \text{ mV},$ | IOT = 0 | −55°C | | 0 | 50 | mV |
| | | | | | 125°C | | 0 | 50 | |
| | Lorgo signal differential v | altaga | | | 25°C | 50 | 800 | | |
| AVD | Large-signal differential vo amplification | Jilage | V _O = 1 V to 6 V, | $R_L = 1 M\Omega$ | −55°C | 25 | 1750 | | V/mV |
| | | | | | 125°C | 25 | 380 | | |
| | | | | | 25°C | 65 | 97 | | |
| CMRR | Common-mode rejection | ratio | $V_{IC} = V_{ICR}min$ | | −55°C | 60 | 97 | | dB |
| | | | | | 125°C | 60 | 91 | | |
| | Supply-voltage rejection ra | atio | | | 25°C | 70 | 97 | | |
| k SVR | $(\Delta V_{DD}/\Delta V_{IO})$ | auo | $V_{DD} = 5 V \text{ to } 10 V,$ | $V_{O} = 1.4 V$ | −55°C | 60 | 97 | | dB |
| | | | | | 125°C | 60 | 98 | | |
| | | | $V_{O} = 5 V_{,}$ | V _{IC} = 5 V, | 25°C | | 57 | 92 | |
| IDD | Supply current (four ampli | ifiers) | VO = 5 V, No load | $V_{\rm IC} = 0 V,$ | −55°C | | 111 | 192 | μA |
| | | | | | 125°C | | 35 | 60 | |

[†] Full range is -55° C to 125° C.

NOTES: 4. The typical values of input bias current and Input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 5 V, T_A = 25°C (unless otherwise noted)

| | PARAMETER | TEST CON | | Т | LC27L4 | <i>,</i> | UNIT |
|------------------|--|---|--|-----------------|-------------------|----------|-------|
| | FARAMETER | TEST CONL | DITIONS | MIN | TYP | MAX | UNIT |
| VIO | Input offset voltage | V _O = 1.4 V, R _S = 50 Ω, | $V_{IC} = 0,$ R _L = 1 M Ω | | 1.1 | 10 | mV |
| ανιο | Average temperature coefficient of input offset voltage | $T_A = 25^{\circ}C$ to $70^{\circ}C$ | | | 1.1 | | μV/°C |
| lio | Input offset current (see Note 4) | V _O = 2.5 V, | V _{IC} = 2.5 V | | 0.1 | | pА |
| I _{IB} | Input bias current (see Note 4) | V _O = 2.5 V, | V _{IC} = 2.5 V | | 0.6 | | pА |
| VICR | Common-mode input voltage range (see Note 5) | | | -0.2 to 4 | -0.3 to 4.2 | | V |
| ∨он | High-level output voltage | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | 3.2 | 4.1 | | V |
| VOL | Low-level output voltage | V _{ID} = -100 mV, | $I_{OL} = 0$ | | 0 | 50 | mV |
| AVD | Large-signal differential voltage amplification | $V_{O} = 0.25 V \text{ to } 2 V,$ | $R_L = 1 M\Omega$ | 50 | 520 | | V/mV |
| CMRR | Common-mode rejection ratio | V _{IC} = V _{ICR} min | | 65 | 94 | | dB |
| k _{SVR} | Supply-voltage rejection ratio ($\Delta V_{DD} / \Delta V_{IO}$) | V _{DD} = 5 V to 10 V, | V _O = 1.4 V | 70 | 97 | | dB |
| IDD | Supply current (four amplifiers) | V _O = 2.5 V, No load | V _{IC} = 2.5 V, | | 40 | 68 | μA |

electrical characteristics at specified free-air temperature, V_{DD} = 10 V, T_A = 25 $^\circ C$ (unless otherwise noted)

| | PARAMETER | TEST CON | | Т | LC27L4 | (| UNIT |
|------------------|--|--|--|-----------------|-------------------|-----|-------|
| | PARAMETER | TESTCON | DITIONS | MIN | TYP | MAX | UNIT |
| VIO | Input offset voltage | $V_{O} = 1.4 V,$ R _S = 50 Ω , | $V_{IC} = 0,$ R _L = 1 M Ω | | 1.1 | 10 | mV |
| αγιο | Average temperature coefficient of input offset voltage | $T_A = 25^{\circ}C$ to $70^{\circ}C$ | | | 1 | | μV/°C |
| IIO | Input offset current (see Note 4) | V _O = 5 V, | $V_{IC} = 5 V$ | | 0.1 | | pА |
| I _{IB} | Input bias current (see Note 4) | V _O = 5 V, | $V_{IC} = 5 V$ | | 0.7 | | pА |
| VICR | Common-mode input voltage range (see Note 5) | | | -0.2 to 9 | -0.3 to 9.2 | | V |
| VOH | High-level output voltage | V _{ID} = 100 mV, | $R_L = 1 M\Omega$ | 8 | 8.9 | | V |
| VOL | Low-level output voltage | V _{ID} = -100 mV, | IOT = 0 | | 0 | 50 | mV |
| AVD | Large-signal differential voltage amplification | $V_{O} = 1 V \text{ to } 6 V,$ | $R_L = 1 M\Omega$ | 50 | 870 | | V/mV |
| CMRR | Common-mode rejection ratio | $V_{IC} = V_{ICR}min$ | | 65 | 97 | | dB |
| k _{SVR} | Supply-voltage rejection ratio $(\Delta V_{DD}/\Delta V_{IO})$ | $V_{DD} = 5 V \text{ to } 10 V,$ | V _O = 1.4 V | 70 | 97 | | dB |
| IDD | Supply current (four amplifiers) | V _O = 5 V, No load | V _{IC} = 5 V, | | 57 | 92 | μA |

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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| | PARAMETER | TEST CO | TEST CONDITIONS | | | TLC27L4C TLC27L4AC TLC27L4BC TLC27L9C | | |
|----------------|--------------------------------|--|---|------|------|--|-----|--------|
| | | | | | MIN | TYP | MAX | |
| | | | | 25°C | | 0.03 | | |
| | | | VIPP = 1 V | 0°C | | 0.04 | |] |
| SR | Claurente et units gein | $R_L = 1 M\Omega$, | | 70°C | | 0.03 | | |
| SK | Slew rate at unity gain | CL = 20 pF, See Figure 1 | | 25°C | 0.03 | | | V/μs |
| | | gere i | V _{IPP} = 2.5 V | 0°C | | 0.03 | | 1 |
| | | | | 70°C | | 0.02 | | 1 |
| Vn | Equivalent input noise voltage | f = 1 kHZ, See Figure 2 | R _S = 20 Ω, | 25°C | 70 | | | nV/√Hz |
| | | | | 25°C | | 5 | | |
| Вом | Maximum output-swing bandwidth | | C _L = 20 pF, See Figure 1 | 0°C | | 6 | | kHz |
| | | | Gee l'igure i | 70°C | | 4.5 | | 1 |
| | | | | 25°C | | 85 | | |
| B ₁ | Unity-gain bandwidth | V _I = 10 mV, See Figure 3 | C _L = 20 pF, | 0°C | | 100 | | kHz |
| | | | | 70°C | | 65 | | 1 |
| | | | <i>.</i> | 25°C | | 34° | | |
| φm | Phase margin | V _I = 10 mV, C _L = 20 pF, | f = B ₁ , See Figure 3 | 0°C | | 36° | | 1 |
| | | | coor iguio o | 70°C | | 30° | | 1 |

operating characteristics at specified free-air temperature, V_{DD} = 5 V

operating characteristics at specified free-air temperature, $V_{DD} = 10 V$

| | PARAMETER | | NDITIONS | T _A | TLC27L4C TLC27L4AC TLC27L4BC TLC27L9C | | | UNIT |
|----------------|--------------------------------|--|---|----------------|--|------|-----|--------|
| | | | | | MIN | TYP | MAX | |
| | | | | 25°C | | 0.05 | | |
| | | | $V_{IPP} = 1 V$ | 0°C | | 0.05 | | |
| SR | $R_L = 1 M\Omega$, | | | 70°C | | 0.04 | | V/uo |
| J SK | Slew rate at unity gain | C _L = 20 pF, See Figure 1 | | 25°C | | 0.04 | | V/μs |
| | | | V _{IPP} = 5.5 V | 0°C | | 0.05 | | 1 |
| | | | | 70°C | 0.04 | | | |
| Vn | Equivalent input noise voltage | f = 1 kHz _, See Figure 2 | R _S = 20 Ω, | 25°C | | 70 | | nV/√Hz |
| | | | | 25°C | | 1 | | |
| ВОМ | Maximum output-swing bandwidth | $V_{O} = V_{OH},$ R _L = 1 M Ω , | C _L = 20 pF, See Figure 1 | 0°C | | 1.3 | | kHz |
| | | $ X_{L} - 1 $ $ V \leq 2$, | See ligure i | 70°C | | 0.9 | | |
| | | | | 25°C | | 110 | | |
| B ₁ | Unity-gain bandwidth | V _I = 10 mV, See Figure 3 | C _L = 20 pF, | 0°C | | 125 | | kHz |
| | | loce rigare e | | 70°C | | 90 | | |
| | | | () | 25°C | | 38° | | |
| ∮m | Phase margin | $V_{I} = 10 \text{ mV},$ $C_{I} = 20 \text{ pF},$ | f = B ₁ , See Figure 3 | 0°C | | 40° | | |
| | | 0L - 20 pr, | eee rigure e | 70°C | | 34° | | |



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operating characteristics at specified free-air temperature, V_{DD} = 5 V

| | PARAMETER | | NDITIONS | TA | TLC27L4I TLC27L4AI TLC27L4BI TLC27L9I MIN TYP MAX | | | UNIT | |
|----------------|--------------------------------|--|--------------------------------------|---------------|---|------|------|--------------------|--|
| | | | 1 | 25°C | MIN | 0.03 | MAX | | |
| | | | | -40°C | | 0.03 | | | |
| | | V _{IPP} = 1 V R _L = 1 ΜΩ, | | _40 C 85°C | | 0.04 | | | |
| SR | Slew rate at unity gain | C _L = 20 pF, | | 25°C | | 0.03 | | V/µs | |
| | | See Figure 1 | See Figure 1 | VIPP = 2.5 V | -40°C | | 0.03 | | |
| | | | 1 IFF = 2.0 1 | 85°C | | 0.02 | | 1 | |
| Vn | Equivalent input noise voltage | f = 1 HZ, See Figure 2 | R _S = 20 Ω, | 25°C | | 70 | | nV/√ Hz | |
| | | | | 25°C | | 5 | | | |
| Вом | Maximum output-swing bandwidth | $V_{O} = V_{OH},$ R _L = 1 M Ω , | $C_L = 20 \text{ pF},$ | -40°C | | 7 | | kHz | |
| | | $R_{L} = 1 \text{ IVIS2},$ | See Figure 1 | 85°C | | 4 | | | |
| | | | | 25°C | | 85 | | | |
| B ₁ | Unity-gain bandwidth | $V_{I} = 10 \text{ mV},$ | C _L = 20 pF, | -40°C | | 130 | | kHz | |
| | See Figure 3 | | | 85°C | | 55 | | | |
| | V 40 mV | | () | 25°C | | 34° | | | |
| φm | | $V_{I} = 10 \text{ mV},$ $C_{L} = 20 \text{ pF},$ | f = B ₁ , See Figure 3 | -40°C | | 38° | | | |
| | | | | 85°C | | 28° | | | |

operating characteristics at specified free-air temperature, V_{DD} = 10 V

| | PARAMETER | | NDITIONS | T _A | TLC27L4I TLC27L4AI TLC27L4BI TLC27L9I | | | UNIT |
|----------------|--------------------------------|---|---|----------------|--|------|-----|--------|
| <u> </u> | | | | | MIN | TYP | MAX | |
| | | | | 25°C | | 0.05 | | |
| | V _{IPP} = 1 V | | -40°C | | 0.06 | | | |
| SR | Slow rate at unity gain | $R_L = 1 M\Omega$, $C_L = 20 pE$ | | 85°C | | 0.03 | | V/µs |
| SK | Siew rate at unity gain | w rate at unity gain C _L = 20 pF, See Figure 1 | | 25°C | | 0.04 | | v/µs |
| | | | VIPP = 2.5 V | -40°C | 0.05 | | | |
| | | | | 85°C | 0.03 | | | |
| V _n | Equivalent input noise voltage | f = 1 HZ, See Figure 2 | R _S = 20 Ω, | 25°C | | 70 | | nV/√Hz |
| | | 1 | | 25°C | | 1 | | |
| ВОМ | Maximum output-swing bandwidth | $V_{O} = V_{OH},$ R _L = 1 M Ω , | C _L = 20 pF, See Figure 1 | -40°C | | 1.4 | | kHz |
| | | $R_{L} = 1 \text{ IVIS2},$ | See Figure 1 | 85°C | | 0.8 | | |
| | | | | 25°C | | 110 | | |
| B ₁ | Unity-gain bandwidth | V _I = 10 mV, See Figure 3 | C _L = 20 pF, | -40°C | | 155 | | kHz |
| | Se | | | 85°C | | 80 | | 1 |
| | | | | 25°C | | 38° | | |
| φm | Phase margin | | f = B ₁ , See Figure 3 | -40°C | | 42° | | 1 |
| | $C_L = 20 \text{ pF},$ | | CCC Figure 5 | 85°C | | 32° | | |



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| | PARAMETER | TEST CO | NDITIONS | ТА | TLC27L4M TLC27L9M | | | UNIT | | |
|----------------|--|--|---|--|----------------------|-------|------|--------|--|-----|
| | | | | | MIN | TYP | MAX | | | |
| | | | | 25°C | | 0.03 | | | | |
| | | | V _{IPP} = 1 V | −55°C | | 0.04 | | | | |
| SR | Slew rate at unity gain $ \begin{array}{c} R_L = 1 \ M\Omega, \\ C_L = 20 \ \text{pF}, \\ \text{See Figure 1} \end{array} \\ \\ V_{IPP} = \ 2.5 \ \text{V} \end{array} $ | | 125°C | | 0.02 | | | | | |
| SK | | | 25°C | | 0.03 | | V/µs | | | |
| | | | VIPP = 2.5 V | −55°C | | 0.04 | | | | |
| | | | | 125°C | | 0.02 | | | | |
| Vn | Equivalent input noise voltage | f = 1 kHz, See Figure 2 | R _S = 20 Ω, | 25°C | | 70 | | nV/√Hz | | |
| | | | | 25°C | | 5 | | | | |
| Вом | Maximum output-swing bandwidth | $V_{O} = V_{OH},$ R _L = 1 M Ω , | C _L = 20 pF, See Figure 1 | −55°C | | 8 | | kHz | | |
| | | | occ rigare r | 125°C | | 3 | | | | |
| | | | 0 00 5 | 25°C | | 85 | | | | |
| B ₁ | Unity-gain bandwidth | | | $V_{I} = 10 \text{ mV}, C_{L} = 20 \text{ pF},$ See Figure 3 | | −55°C | | 140 | | kHz |
| | | See Figure 5 | | 125°C | | 45 | | | | |
| | Phase margin | 10 | <u> </u> | 25°C | | 34° | | | | |
| φm | | V _I = 10 mV, C _L = 20 pF, | f = B ₁ , See Figure 3 | −55°C | | 39° | | | | |
| TIII | | | | 125°C | | 25° | | | | |

operating characteristics at specified free-air temperature, V_{DD} = 5 V

operating characteristics at specified free-air temperature, $V_{DD} = 10 V$

| | PARAMETER | TEST CO | NDITIONS | тд | | LC27L4 LC27L9 | | UNIT |
|----------------|---|---|-----------------------------|-------|-----|------------------|-----|--------------------|
| | | | | ~ | MIN | TYP | MAX | |
| | | | | 25°C | | 0.05 | | |
| | | | V _{IPP} = 1 V | −55°C | | 0.06 | | |
| SR | Clow rate at unity gain | | | 125°C | | 0.03 | |)//uo |
| J SR | Slew rate at unity gain | | | 25°C | | 0.04 | | V/μs |
| | | | | −55°C | | 0.06 | | |
| | | | | 125°C | | 0.03 | | |
| Vn | Equivalent input noise voltage | f = 1 kHz, See Figure 2 | R _S = 20 Ω, | 25°C | | 70 | | nV/√ Hz |
| | | | | 25°C | | 1 | | |
| ВОМ | Maximum output-swing bandwidth | $V_{O} = V_{OH}, C_{L} = 2$ $R_{L} = 1 M\Omega, See F$ | CL = 20 pF, See Figure 1 | −55°C | | 1.5 | | kHz |
| | | 1 (<u></u> 1 1 1 1 1 2 , | occ rigare r | 125°C | | 0.7 | | |
| | | | · · · · | 25°C | | 110 | | |
| B ₁ | Unity-gain bandwidth | V _I = 10 mV, See Figure 3 | C _L = 20 pF, | −55°C | | 165 | | kHz |
| | | Occ rigure 3 | | 125°C | | 70 | | |
| | | 10 m)(| 4 D | 25°C | | 38° | | |
| ∮m | Phase margin $V_{I} = 10 \text{ mV}, f = B_{1}, \\ C_{L} = 20 \text{ pF}, \text{See Figure 3} -55^{\circ}\text{C} 43^{\circ}$ | 43° | | | | | | |
| | | • •, | gui e e | 125°C | | 29° | | |



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operating characteristics, $V_{DD} = 5 V$, $T_A = 25^{\circ}C$

| | PARAMETER | TEST CO | NDITIONS | TL | .C27L4Y | ' | UNIT |
|----------------|--------------------------------|--|---|-----|---------|-----|--------|
| | PARAMETER | TEST CO | NDITIONS | MIN | TYP | MAX | UNIT |
| SR | Slew rate at unity gain | $R_L = 1 M\Omega,$ $C_I = 20 pF,$ | V _{IPP} = 1 V | | 0.03 | | V/µs |
| SK | Siew rate at unity gain | See Figure 1 | V _{IPP} = 2.5 V | | 0.03 | | v/μs |
| Vn | Equivalent input noise voltage | f = 1 kHz, See Figure 2 | $R_S = 20 \Omega$, | | 70 | | nV/√Hz |
| вом | Maximum output-swing bandwidth | $V_{O} = V_{OH},$ R _L = 1 M Ω , | C _L = 20 pF, See Figure 1 | | 5 | | kHz |
| В ₁ | Unity-gain bandwidth | V _I = 10 mV, See Figure 3 | C _L = 20 pF, | | 85 | | kHz |
| [¢] m | Phase margin | $V_{I} = 10 \text{ mV},$ $C_{L} = 20 \text{ pF},$ | f = B ₁ , See Figure 3 | | 34° | | |

operating characteristics, V_{DD} = 10 V, T_A = 25°C

| | PARAMETER | TEST CO | NDITIONS | TL | .C27L4Y | ' | UNIT |
|----------------|--------------------------------|--|---|-----|---------|----------|--------|
| | FARAIWETER | TEST CO | NDITIONS | MIN | TYP | MAX | UNIT |
| SR | Slew rate at unity gain | $R_L = 1 M\Omega$, $C_I = 20 pF$, | V _{IPP} = 1 V | | 0.05 | | V/µs |
| - Six | Siew rate at unity gain | See Figure 1 | V _{IPP} = 5.5 V | | 0.04 | | ν/μ5 |
| Vn | Equivalent input noise voltage | f = 1 kHz, See Figure 2 | $R_{S} = 20 \Omega$, | | 70 | | nV/√Hz |
| BOM | Maximum output-swing bandwidth | $V_{O} = V_{OH},$ R _L = 1 M Ω , | C _L = 20 pF, See Figure 1 | | 1 | | kHz |
| В ₁ | Unity-gain bandwidth | V _I = 10 mV, See Figure 3 | C _L = 20 pF, | | 110 | | kHz |
| [¢] m | Phase margin | $V_{I} = 10 \text{ mV},$ $C_{L} = 20 \text{ pF},$ | f = B ₁ , See Figure 3 | | 38° | | |

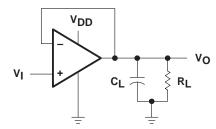


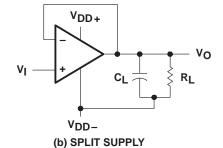
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PARAMETER MEASUREMENT INFORMATION

single-supply versus split-supply test circuits

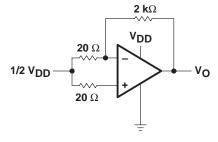
Because the TLC27L4 and TLC27L9 are optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit gives the same result.

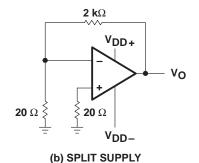




(a) SINGLE SUPPLY

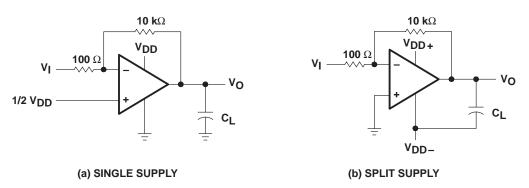






(a) SINGLE SUPPLY

Figure 2. Noise-Test Circuit







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PARAMETER MEASUREMENT INFORMATION

input bias current

Because of the high input impedance of the TLC27L4 and TLC27L9 operational amplifiers, attempts to measure the input bias current can result in erroneous readings. The bias current at normal room ambient temperature is typically less than 1 pA, a value that is easily exceeded by leakages on the test socket. Two suggestions are offered to avoid erroneous measurements:

- 1. Isolate the device from other potential leakage sources. Use a grounded shield around and between the device inputs (see Figure 4). Leakages that would otherwise flow to the inputs are shunted away.
- 2. Compensate for the leakage of the test socket by actually performing an input bias current test (using a picoammeter) with no device in the test socket. The actual input bias current can then be calculated by subtracting the open-socket leakage readings from the readings obtained with a device in the test socket.

One word of caution: many automatic testers as well as some bench-top operational amplifier testers use the servo-loop technique with a resistor in series with the device input to measure the input bias current (the voltage drop across the series resistor is measured and the bias current is calculated). This method requires that a device be inserted into the test socket to obtain a correct reading; therefore, an open-socket reading is not feasible using this method.

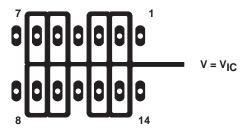


Figure 4. Isolation Metal Around Device Inputs (J and N packages)

low-level output voltage

To obtain low-supply-voltage operation, some compromise was necessary in the input stage. This compromise results in the device low-level output being dependent on both the common-mode input voltage level as well as the differential input voltage level. When attempting to correlate low-level output readings with those quoted in the electrical specifications, these two conditions should be observed. If conditions other than these are to be used, please refer to Figures 14 through 19 in the Typical Characteristics of this data sheet.

input offset voltage temperature coefficient

Erroneous readings often result from attempts to measure temperature coefficient of input offset voltage. This parameter is actually a calculation using input offset voltage measurements obtained at two different temperatures. When one (or both) of the temperatures is below freezing, moisture can collect on both the device and the test socket. This moisture results in leakage and contact resistance, which can cause erroneous input offset voltage readings. The isolation techniques previously mentioned have no effect on the leakage since the moisture also covers the isolation metal itself, thereby rendering it useless. It is suggested that these measurements be performed at temperatures above freezing to minimize error.



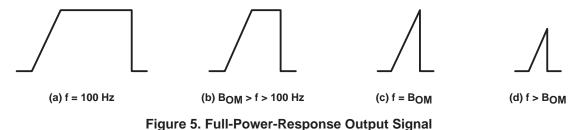
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PARAMETER MEASUREMENT INFORMATION

full-power response

Full-power response, the frequency above which the operational amplifier slew rate limits the output voltage swing, is often specified two ways: full-linear response and full-peak response. The full-linear response is generally measured by monitoring the distortion level of the output while increasing the frequency of a sinusoidal input signal until the maximum frequency is found above which the output contains significant distortion. The full-peak response is defined as the maximum output frequency, without regard to distortion, above which full peak-to-peak output swing cannot be maintained.

Because there is no industry-wide accepted value for significant distortion, the full-peak response is specified in this data sheet and is measured using the circuit of Figure 1. The initial setup involves the use of a sinusoidal input to determine the maximum peak-to-peak output of the device (the amplitude of the sinusoidal wave is increased until clipping occurs). The sinusoidal wave is then replaced with a square wave of the same amplitude. The frequency is then increased until the maximum peak-to-peak output can no longer be maintained (Figure 5). A square wave is used to allow a more accurate determination of the point at which the maximum peak-to-peak output is reached.



test time

Inadequate test time is a frequent problem, especially when testing CMOS devices in a high-volume, short-test-time environment. Internal capacitances are inherently higher in CMOS than in bipolar and BiFET devices and require longer test times than their bipolar and BiFET counterparts. The problem becomes more pronounced with reduced supply levels and lower temperatures.



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TYPICAL CHARACTERISTICS

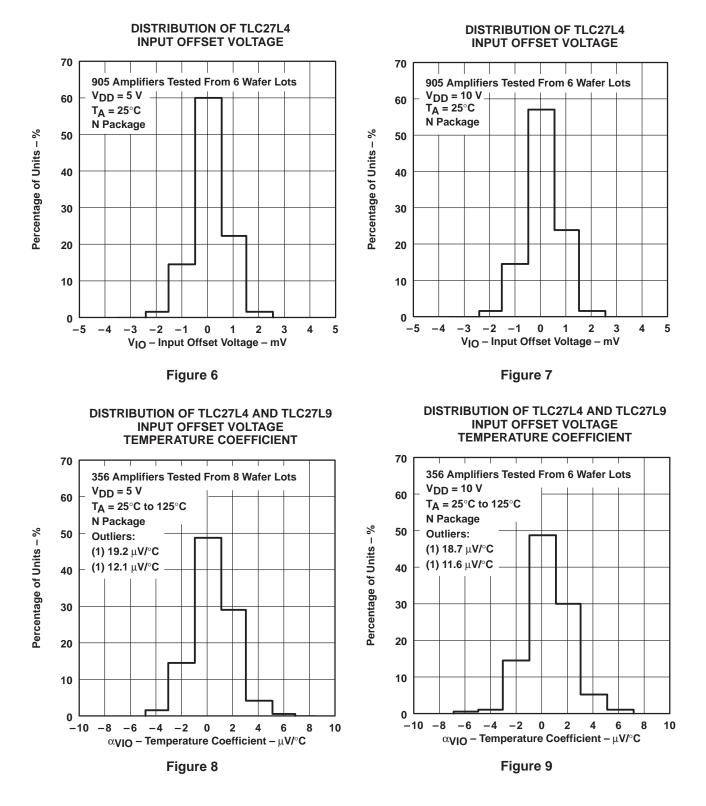
| | | | FIGURE |
|--------------------|-------------------------------------|---|------------------------------|
| VIO | Input offset voltage | Distribution | 6, 7 |
| αVIO | Temperature coefficient | Distribution | 8, 9 |
| VOH | High-level output voltage | vs High-level output current vs Supply voltage vs Free-air temperature | 10, 11 12 13 |
| V _{OL} | Low-level output voltage | vs Common-mode input voltage vs Differential input voltage vs Free-air temperature vs Low-level output current | 14, 15 16 17 18, 19 |
| AVD | Differential voltage amplification | vs Supply voltage vs Free-air temperature vs Frequency | 20 21 32, 33 |
| IIB/IIO | Input bias and input offset current | vs Free-air temperature | 22 |
| VIC | Common-mode input voltage | vs Supply voltage | 23 |
| IDD | Supply current | vs Supply voltage vs Free-air temperature | 24 25 |
| SR | Slew rate | vs Supply voltage vs Free-air temperature | 26 27 |
| | Normalized slew rate | vs Free-air temperature | 28 |
| V _{O(PP)} | Maximum peak-to-peak output voltage | vs Frequency | 29 |
| B ₁ | Unity-gain bandwidth | vs Free-air temperature vs Supply voltage | 30 31 |
| [¢] m | Phase margin | vs Supply voltage vs Free-air temperature vs Capacitive loads | 34 35 36 |
| Vn | Equivalent input noise voltage | vs Frequency | 37 |
| φ | Phase shift | vs Frequency | 32, 33 |

Table of Graphs



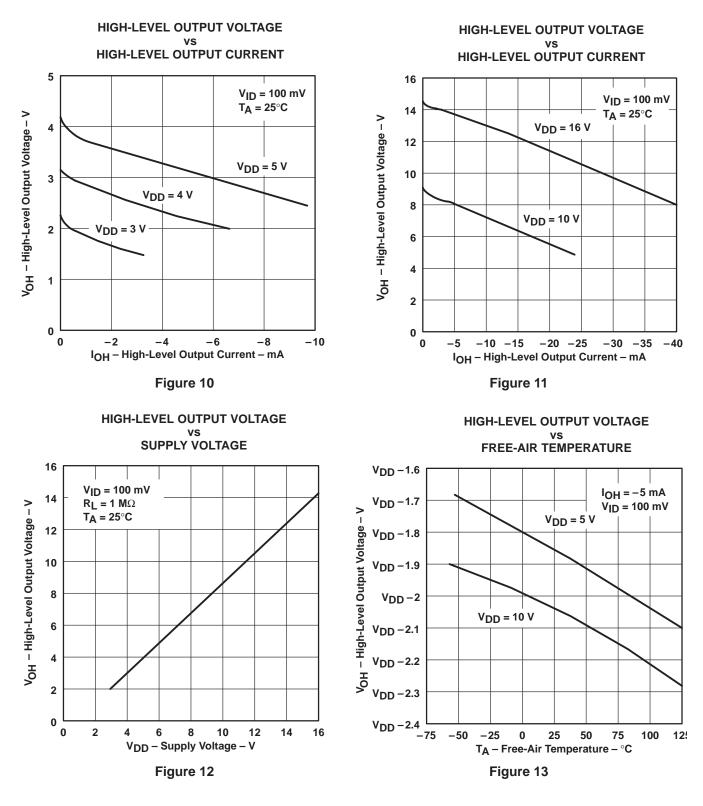
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TYPICAL CHARACTERISTICS





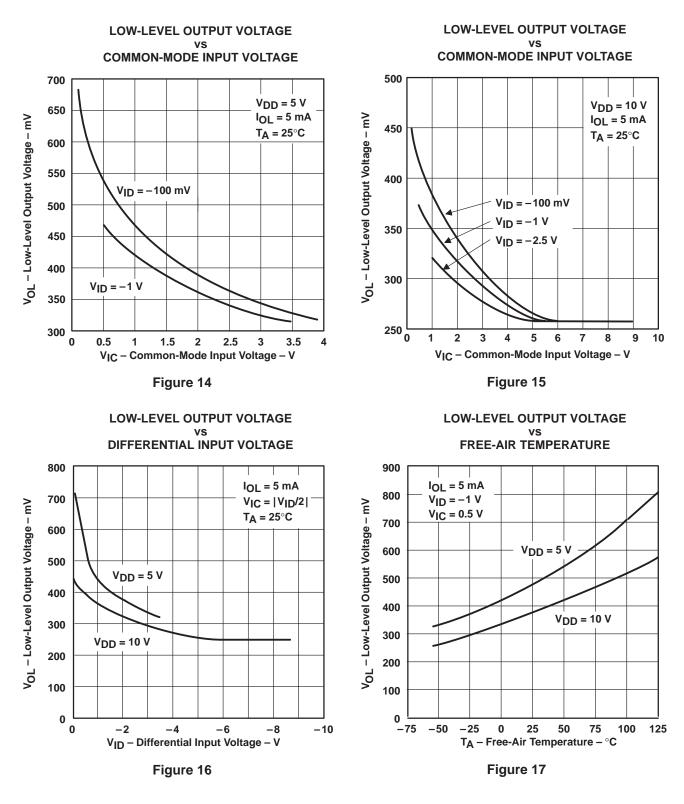
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TYPICAL CHARACTERISTICS[†]



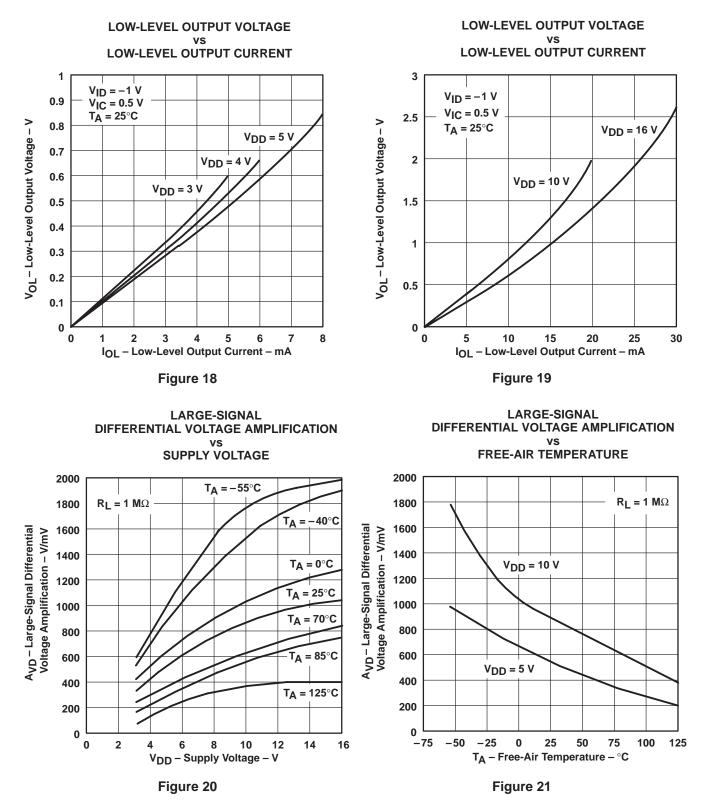
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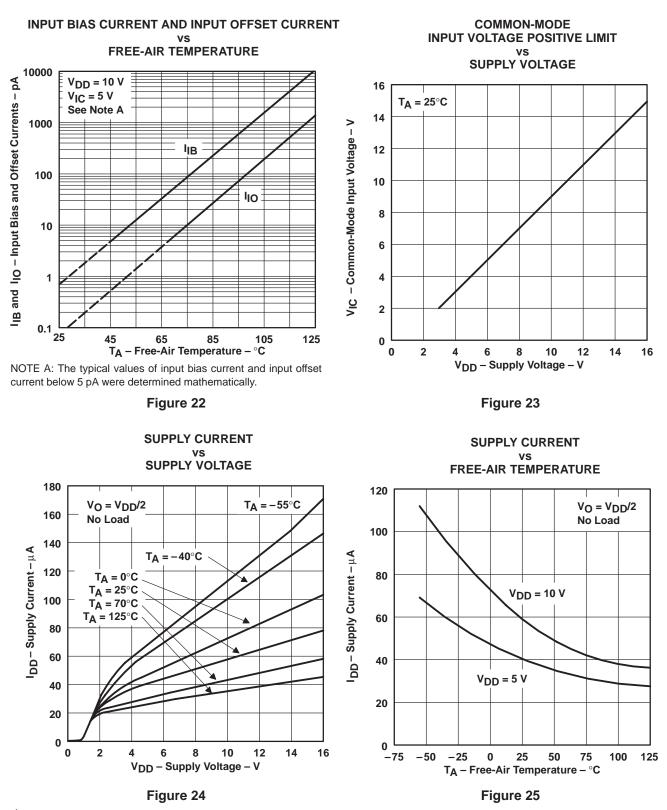
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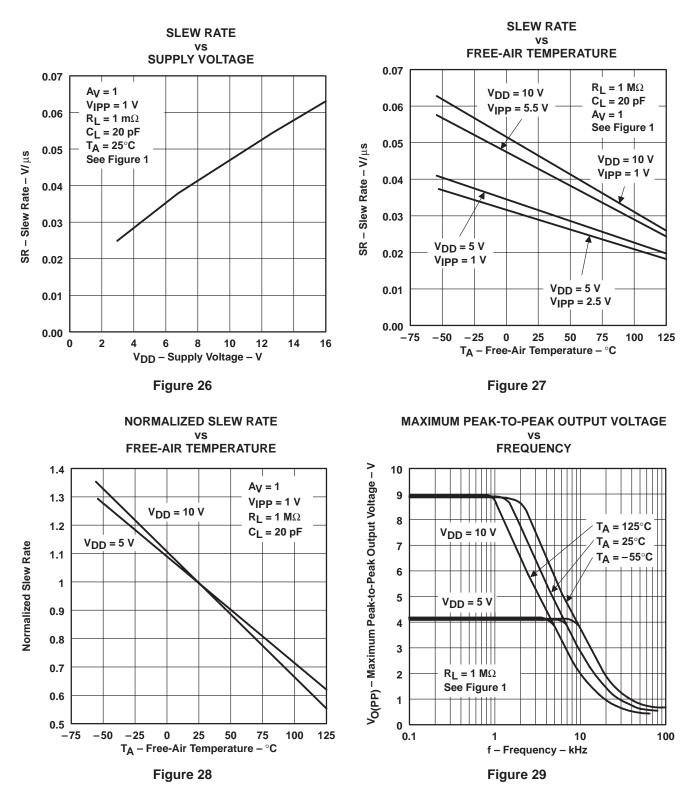
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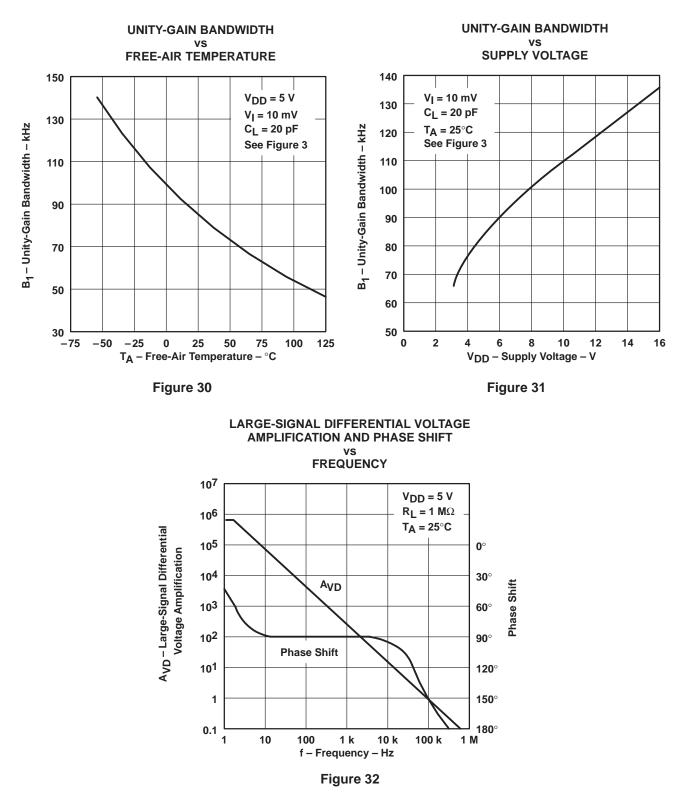
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TYPICAL CHARACTERISTICS[†]



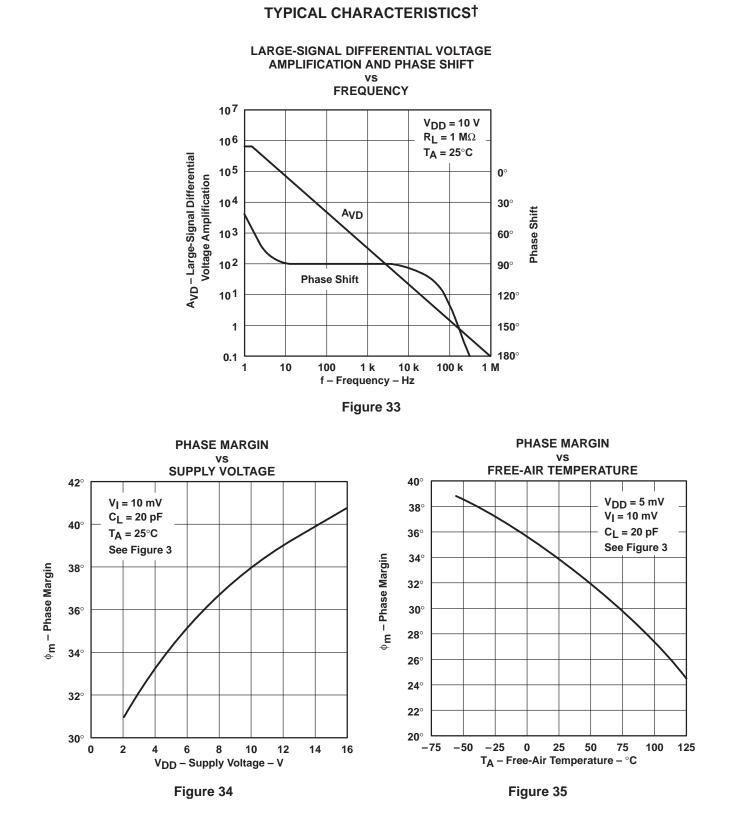
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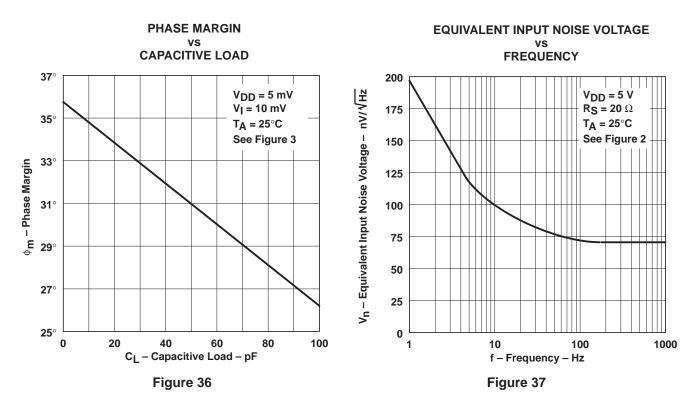
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TYPICAL CHARACTERISTICS





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APPLICATION INFORMATION

single-supply operation

While the TLC27L4 and TLC27L9 perform well using dual power supplies (also called balanced or split supplies), the design is optimized for single-supply operation. This design includes an input common-mode voltage range that encompasses ground as well as an output voltage range that pulls down to ground. The supply voltage range extends down to 3 V (C-suffix types), thus allowing operation with supply levels commonly available for TTL and HCMOS; however, for maximum dynamic range, 16-V single-supply operation is recommended.

Many single-supply applications require that a voltage be applied to one input to establish a reference level that is above ground. A resistive voltage divider is usually sufficient to establish this reference level (see Figure 38). The low input bias current of the TLC27L4 and TLC27L9 permits the use of very large resistive values to implement the voltage divider, thus minimizing power consumption.

The TLC27L4 and TLC27L9 work well in conjunction with digital logic; however, when powering both linear devices and digital logic from the same power supply, the following precautions are recommended:

- 1. Power the linear devices from separate bypassed supply lines (see Figure 39); otherwise, the linear device supply rails can fluctuate due to voltage drops caused by high switching currents in the digital logic.
- 2. Use proper bypass techniques to reduce the probability of noise-induced errors. Single capacitive decoupling is often adequate; however, high-frequency applications may require RC decoupling.

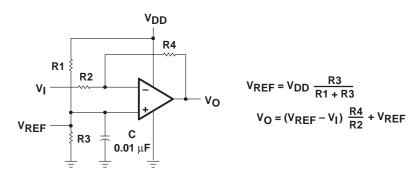
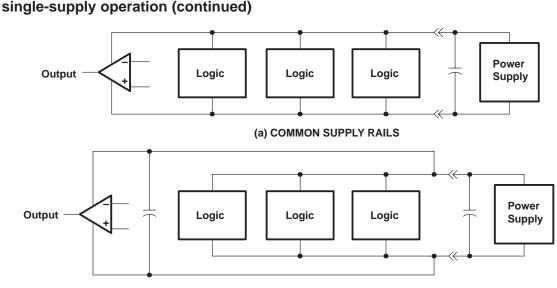


Figure 38. Inverting Amplifier With Voltage Reference



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APPLICATION INFORMATION



(b) SEPARATE BYPASSED SUPPLY RAILS (preferred)

Figure 39. Common Versus Separate Supply Rails

input characteristics

The TLC27L4 and TLC27L9 are specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction. Exceeding this specified range is a common problem, especially in single-supply operation. Note that the lower range limit includes the negative rail, while the upper range limit is specified at $V_{DD} - 1$ V at $T_A = 25^{\circ}$ C and at $V_{DD} - 1.5$ V at all other temperatures.

The use of the polysilicon-gate process and the careful input circuit design gives the TLC27L4 and TLC27L9 very good input offset voltage drift characteristics relative to conventional metal-gate processes. Offset voltage drift in CMOS devices is highly influenced by threshold voltage shifts caused by polarization of the phosphorus dopant implanted in the oxide. Placing the phosphorus dopant in a conductor (such as a polysilicon gate) alleviates the polarization problem, thus reducing threshold voltage shifts by more than an order of magnitude. The offset voltage drift with time has been calculated to be typically 0.1 μ V/month, including the first month of operation.

Because of the extremely high input impedance and resulting low bias current requirements, the TLC27L4 and TLC27L9 are well suited for low-level signal processing; however, leakage currents on printed circuit boards and sockets can easily exceed bias current requirements and cause a degradation in device performance. It is good practice to include guard rings around inputs (similar to those of Figure 4 in the Parameter Measurement Information section). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input (see Figure 40).

The inputs of any unused amplifiers should be tied to ground to avoid possible oscillation.

noise performance

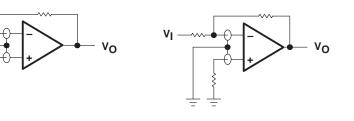
The noise specifications in operational amplifier circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias current requirements of the TLC27L4 and TLC27L9 result in a very low noise current, which is insignificant in most applications. This feature makes the devices especially favorable over bipolar devices when using values of circuit impedance greater than 50 k Ω , since bipolar devices exhibit greater noise currents.



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APPLICATION INFORMATION

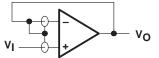
noise performance (continued)



(a) NONINVERTING AMPLIFIER

(b) INVERTING AMPLIFIER

Figure 40. Guard-Ring Schemes

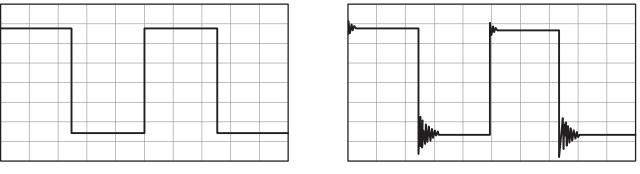


(c) UNITY-GAIN AMPLIFIER

output characteristics

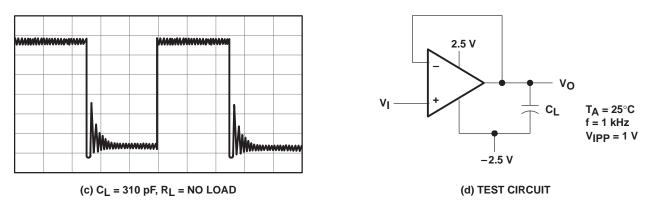
The output stage of the TLC27L4 and TLC27L9 is designed to sink and source relatively high amounts of current (see typical characteristics). If the output is subjected to a short-circuit condition, this high current capability can cause device damage under certain conditions. Output current capability increases with supply voltage.

All operating characteristics of the TLC27L4 and TLC27L9 were measured using a 20-pF load. The devices drive higher capacitive loads; however, as output load capacitance increases, the resulting response pole occurs at lower frequencies, thereby causing ringing, peaking, or even oscillation (see Figure 41). In many cases, adding a small amount of resistance in series with the load capacitance alleviates the problem.



(a) $C_L = 20 \text{ pF}$, $R_L = \text{NO LOAD}$









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APPLICATION INFORMATION

output characteristics (continued)

Although the TLC27L4 and TLC27L9 possess excellent high-level output voltage and current capability, methods for boosting this capability are available, if needed. The simplest method involves the use of a pullup resistor (Rb) connected from the output to the positive supply rail (see Figure 42). There are two disadvantages to the use of this circuit. First, the NMOS pulldown transistor N4 (see equivalent schematic) must sink a comparatively large amount of current. In this circuit, N4 behaves like a linear resistor with an on-resistance between approximately 60Ω and 180Ω , depending on how hard the operational amplifier input is driven. With very low values of R_P, a voltage offset from 0 V at the output occurs. Second, pullup resistor R_P acts as a drain load to N4 and the gain of the operational amplifier is reduced at output voltage levels where N5 is not supplying the output current.

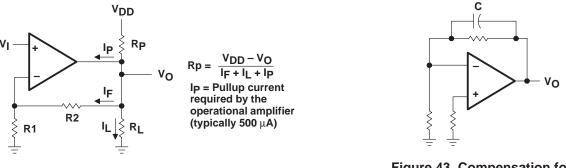


Figure 42. Resistive Pullup to Increase VOH



feedback

Operational amplifier circuits nearly always employ feedback, and since feedback is the first prerequisite for oscillation, some caution is appropriate. Most oscillation problems result from driving capacitive loads (discussed previously) and ignoring stray input capacitance. A small-value capacitor connected in parallel with the feedback resistor is an effective remedy (see Figure 43). The value of this capacitor is optimized empirically.

electrostatic discharge protection

The TLC27L4 and TLC27L9 incorporate an internal electrostatic discharge (ESD) protection circuit that prevents functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2. Care should be exercised, however, when handling these devices, as exposure to ESD may result in the degradation of the device parametric performance. The protection circuit also causes the input bias currents to be temperature dependent and have the characteristics of a reverse-biased diode.

latch-up

Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC27L4 and TLC27L9 inputs and outputs were designed to withstand -100-mA surge currents without sustaining latch-up; however, techniques should be used to reduce the chance of latch-up whenever possible. Internal protection diodes should not, by design, be forward biased. Applied input and output voltage should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.



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APPLICATION INFORMATION

latch-up (continued)

The current path established if latch-up occurs is usually between the positive supply rail and ground and can be triggered by surges on the supply lines and/or voltages on either the output or inputs that exceed the supply voltage. Once latch-up occurs, the current flow is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor and usually results in the destruction of the device. The chance of latch-up occurring increases with increasing temperature and supply voltages.

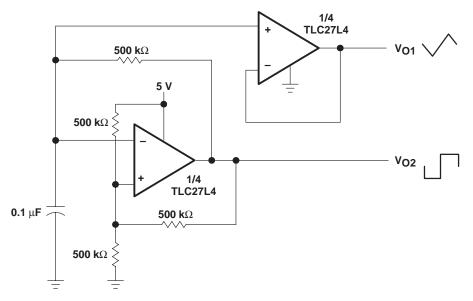
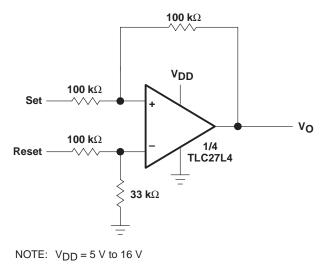


Figure 44. Multivibrator

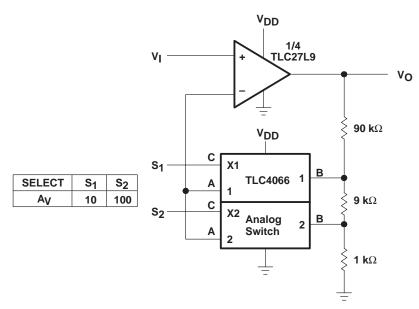






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APPLICATION INFORMATION



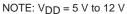
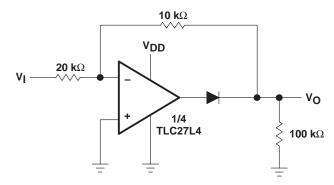
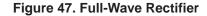


Figure 46. Amplifier With Digital Gain Selection



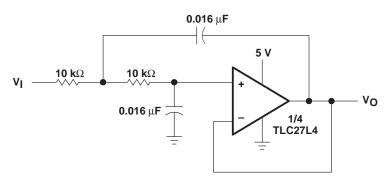
NOTE: $V_{DD} = 5 V$ to 16 V





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APPLICATION INFORMATION



NOTE: Normalized to F_C = 1 kHz and R_L = 10 k\Omega



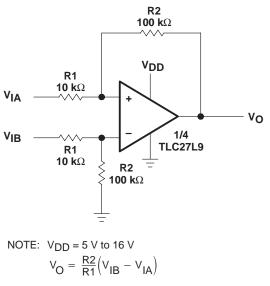


Figure 49. Difference Amplifier



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PACKAGING INFORMATION

TEXAS INSTRUMENTS www.ti.com

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| TLC27L4ACD | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4ACDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4ACDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4ACDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4ACN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4ACNE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4AID | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4AIDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4AIDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4AIDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4AIN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4AINE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4BCD | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4BCDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4BCDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4BCDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4BCN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4BCNE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4BID | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4BIDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4BIDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4BIDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L4BIN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4BINE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4CD | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |

PACKAGE OPTION ADDENDUM

20-Oct-2008

| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Package Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finish | MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|------|----------------|---------------------------|------------------|------------------------------|
| TLC27L4CDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4CNE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4CNSR | ACTIVE | SO | NS | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CNSRG4 | ACTIVE | SO | NS | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CPW | ACTIVE | TSSOP | PW | 14 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CPWG4 | ACTIVE | TSSOP | PW | 14 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CPWLE | OBSOLETE | TSSOP | PW | 14 | | TBD | Call TI | Call TI |
| TLC27L4CPWR | ACTIVE | TSSOP | PW | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4CPWRG4 | ACTIVE | TSSOP | PW | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4ID | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4INE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L4IPW | ACTIVE | TSSOP | PW | 14 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IPWG4 | ACTIVE | TSSOP | PW | 14 | 90 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IPWR | ACTIVE | TSSOP | PW | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4IPWRG4 | ACTIVE | TSSOP | PW | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L4MFKB | OBSOLETE | LCCC | FK | 20 | | TBD | Call TI | Call TI |
| TLC27L4MJ | OBSOLETE | CDIP | J | 14 | | TBD | Call TI | Call TI |
| TLC27L4MJB | OBSOLETE | CDIP | J | 14 | | TBD | Call TI | Call TI |
| TLC27L9CD | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L9CDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L9CDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & | Call TI | Level-1-260C-UNLIM |



| Orderable Device | Status ⁽¹⁾ | Package Type | Package Drawing | Pins | Packag Qty | e Eco Plan ⁽²⁾ | Lead/Ball Finisl | n MSL Peak Temp ⁽³⁾ |
|------------------|-----------------------|-----------------|--------------------|------|---------------|---------------------------|------------------|--------------------------------|
| | | | | | | no Sb/Br) | | |
| TLC27L9CDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L9CN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L9CNE4 | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L9CNSR | ACTIVE | SO | NS | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L9CNSRG4 | ACTIVE | SO | NS | 14 | 2000 | Green (RoHS & no Sb/Br) | CU NIPDAU | Level-1-260C-UNLIM |
| TLC27L9ID | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L9IDG4 | ACTIVE | SOIC | D | 14 | 50 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L9IDR | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L9IDRG4 | ACTIVE | SOIC | D | 14 | 2500 | Green (RoHS & no Sb/Br) | Call TI | Level-1-260C-UNLIM |
| TLC27L9IN | ACTIVE | PDIP | Ν | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L9INE4 | ACTIVE | PDIP | N | 14 | 25 | Pb-Free (RoHS) | CU NIPDAU | N / A for Pkg Type |
| TLC27L9MFKB | OBSOLETE | LCCC | FK | 20 | | TBD | Call TI | Call TI |
| TLC27L9MJ | OBSOLETE | CDIP | J | 14 | | TBD | Call TI | Call TI |
| TLC27L9MJB | OBSOLETE | CDIP | J | 14 | | TBD | Call TI | Call TI |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. **TBD**: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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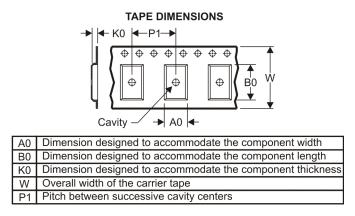
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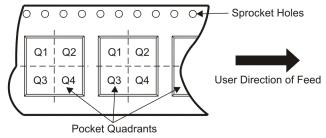
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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



| Device | Package Type | Package Drawing | | SPQ | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-------------|-----------------|--------------------|----|------|--------------------------|--------------------------|---------|---------|---------|------------|-----------|------------------|
| TLC27L4ACDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4ACDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4AIDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4BCDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4BIDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4CDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4CDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4CNSR | SO | NS | 14 | 2000 | 330.0 | 16.4 | 8.2 | 10.5 | 2.5 | 12.0 | 16.0 | Q1 |
| TLC27L4CPWR | TSSOP | PW | 14 | 2000 | 330.0 | 12.4 | 7.0 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TLC27L4IDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L4IPWR | TSSOP | PW | 14 | 2000 | 330.0 | 12.4 | 7.0 | 5.6 | 1.6 | 8.0 | 12.0 | Q1 |
| TLC27L9CDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |
| TLC27L9CNSR | SO | NS | 14 | 2000 | 330.0 | 16.4 | 8.2 | 10.5 | 2.5 | 12.0 | 16.0 | Q1 |
| TLC27L9IDR | SOIC | D | 14 | 2500 | 330.0 | 16.4 | 6.5 | 9.0 | 2.1 | 8.0 | 16.0 | Q1 |



PACKAGE MATERIALS INFORMATION

6-Nov-2008



| *All dimensions are nominal | | | | | | | |
|-----------------------------|--------------|-----------------|------|------|-------------|------------|-------------|
| Device | Package Type | Package Drawing | Pins | SPQ | Length (mm) | Width (mm) | Height (mm) |
| TLC27L4ACDR | SOIC | D | 14 | 2500 | 333.2 | 345.9 | 28.6 |
| TLC27L4ACDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L4AIDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L4BCDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L4BIDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L4CDR | SOIC | D | 14 | 2500 | 333.2 | 345.9 | 28.6 |
| TLC27L4CDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L4CNSR | SO | NS | 14 | 2000 | 346.0 | 346.0 | 33.0 |
| TLC27L4CPWR | TSSOP | PW | 14 | 2000 | 346.0 | 346.0 | 29.0 |
| TLC27L4IDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L4IPWR | TSSOP | PW | 14 | 2000 | 346.0 | 346.0 | 29.0 |
| TLC27L9CDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |
| TLC27L9CNSR | SO | NS | 14 | 2000 | 346.0 | 346.0 | 33.0 |
| TLC27L9IDR | SOIC | D | 14 | 2500 | 346.0 | 346.0 | 33.0 |

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